## P－Channel 30－V（D－S）MOSFET

| PRODUCT SUMMARY |  |  |  |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{DS}}(\mathrm{V})$ | $\mathbf{R}_{\mathrm{DS}(\text { on })}(\Omega)$ | $\mathbf{I}_{\mathbf{D}}(\mathbf{A})^{\mathbf{d}}$ | $\mathbf{Q}_{\mathbf{g}}$（Typ．） |
| -30 | 0.018 at $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}$ | -9.0 | 13 nC |
|  | 0.024 at $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}$ | -7.8 |  |

## FEATURES

－Halogen－free According to IEC 61249－2－21 Definition
－TrenchFET ${ }^{\circledR}$ Power MOSFET
－ $100 \% R_{g}$ Tested


RoHS COMPLIANT halogen FREE Available

APPLICATIONS
－Load Switch
－Battery Switch

SO－8



P－Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ ，unless otherwise noted |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| Parameter |  | Symbol | Limit | Unit |
| Drain－Source Voltage |  | $\mathrm{V}_{\mathrm{DS}}$ | －30 | V |
| Gate－Source Voltage |  | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 20$ |  |
| Continuous Drain Current（ $\mathrm{T}_{J}=150{ }^{\circ} \mathrm{C}$ ） | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $I_{\text {D }}$ | －9．0 | A |
|  | $\mathrm{T}_{\mathrm{C}}=70^{\circ} \mathrm{C}$ |  | －7．2 |  |
|  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  | $-7.0^{\text {a，b }}$ |  |
|  | $\mathrm{T}_{\mathrm{A}}=70^{\circ} \mathrm{C}$ |  | $-5.6^{\text {a，b }}$ |  |
| Pulsed Drain Current |  | IDM | －30 |  |
| Continuous Source－Drain Diode Current | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | Is | －3．5 |  |
|  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  | $-2.1^{\text {a，b }}$ |  |
| Maximum Power Dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 4.2 | W |
|  | $\mathrm{T}_{\mathrm{C}}=70^{\circ} \mathrm{C}$ |  | 2.7 |  |
|  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  | $2.5{ }^{\text {a，b }}$ |  |
|  | $\mathrm{T}_{\text {A }}=70^{\circ} \mathrm{C}$ |  | $1.6{ }^{\text {a，b }}$ |  |
| Operating Junction and Storage Temperature Range |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | －55 to 150 | ${ }^{\circ} \mathrm{C}$ |

## THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Typical | Maximum | Unit |  |
| :--- | :---: | :---: | :---: | :---: | :---: |
| ${\text { Maximum Junction－to－Ambient }{ }^{\text {a，} \mathrm{C}}} \quad \mathrm{t} \leq 10 \mathrm{~s}$ | $\mathrm{R}_{\mathrm{th} J \mathrm{~A}}$ | 40 | 50 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |
| Maximum Junction－to－Foot | Steady State | $\mathrm{R}_{\mathrm{th} J F}$ | 24 |  |  |

Notes：
a．Surface mounted on 1＂x 1＂FR4 board．
b．$t=10 \mathrm{~s}$ ．
c．Maximum under Steady State conditions is $95^{\circ} \mathrm{C} / \mathrm{W}$ ．
d．Based on $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ ．

| Parameter | Symbol | Test Conditions | Min． | Typ． | Max． | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Static |  |  |  |  |  |  |
| Drain－Source Breakdown Voltage | $\mathrm{V}_{\mathrm{DS}}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ | － 30 |  |  | V |
| $\mathrm{V}_{\mathrm{DS}}$ Temperature Coefficient | $\Delta \mathrm{V}_{\mathrm{DS}} / \mathrm{T}_{J}$ | $\mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ |  | －31 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{V}_{\mathrm{GS} \text {（th）}}$ Temperature Coefficient | $\Delta \mathrm{V}_{\mathrm{GS}(\mathrm{th})} / \mathrm{T}_{\mathrm{J}}$ |  |  | 4.5 |  |  |
| Gate－Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS} \text {（th）}}$ | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ | －1．0 |  | －2．5 | V |
| Gate－Source Leakage | IGSS | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ |  |  | $\pm 100$ | nA |
| Zero Gate Voltage Drain Current | IDSS | $\mathrm{V}_{\mathrm{DS}}=-30 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  | －1 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=-30 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{J}=55^{\circ} \mathrm{C}$ |  |  | －5 |  |
| On－State Drain Current ${ }^{\text {a }}$ | $\mathrm{I}_{\mathrm{D} \text {（on）}}$ | $\mathrm{V}_{\mathrm{DS}} \leq-5 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=-10 \mathrm{~V}$ | －20 |  |  | A |
| Drain－Source On－State Resistance ${ }^{\text {a }}$ | $\mathrm{R}_{\mathrm{DS} \text {（on）}}$ | $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-7.0 \mathrm{~A}$ |  | 0.018 |  | $\Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-5.6 \mathrm{~A}$ |  | 0.024 |  |  |
| Forward Transconductance ${ }^{\text {a }}$ | $\mathrm{g}_{\text {fs }}$ | $\mathrm{V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-7.0 \mathrm{~A}$ |  | 18 |  | S |
| Dynamic ${ }^{\text {b }}$ |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\mathrm{V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |  | 1455 |  | pF |
| Output Capacitance | $\mathrm{C}_{\text {oss }}$ |  |  | 180 |  |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  |  | 145 |  |  |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-7.0 \mathrm{~A}$ |  | 25 | 38 | $n \mathrm{C}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=-15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-7.0 \mathrm{~A}$ |  | 13 | 20 |  |
| Gate－Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ |  |  | 3.5 |  |  |
| Gate－Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ |  |  | 5.5 |  |  |
| Gate Resistance | $\mathrm{R}_{\mathrm{g}}$ | $\mathrm{f}=1 \mathrm{MHz}$ | 0.4 | 2.0 | 4.0 | $\Omega$ |
| Turn－On Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | $\begin{gathered} \mathrm{V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=2.7 \Omega \\ \mathrm{I}_{\mathrm{D}} \cong-5.6 \mathrm{~A}, \mathrm{~V}_{\mathrm{GEN}}=-10 \mathrm{~V}, \mathrm{R}_{\mathrm{g}}=1 \Omega \end{gathered}$ |  | 10 | 20 | ns |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  |  | 13 | 20 |  |
| Turn－Off DelayTime | $\mathrm{t}_{\mathrm{d} \text {（off）}}$ |  |  | 23 | 35 |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  |  | 9 | 18 |  |
| Turn－On Delay Time | $\mathrm{t}_{\mathrm{d} \text {（on）}}$ | $\begin{gathered} \mathrm{V}_{\mathrm{DD}}=-15 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=2.7 \Omega \\ \mathrm{I}_{\mathrm{D}} \cong-5.6 \mathrm{~A}, \mathrm{~V}_{\mathrm{GEN}}=-4.5 \mathrm{~V}, \mathrm{R}_{\mathrm{g}}=1 \Omega \end{gathered}$ |  | 38 | 57 |  |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  |  | 89 | 134 |  |
| Turn－Off DelayTime | $\mathrm{t}_{\mathrm{d} \text {（off）}}$ |  |  | 22 | 33 |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  |  | 11 | 17 |  |
| Drain－Source Body Diode Characteristics |  |  |  |  |  |  |
| Continous Source－Drain Diode Current | $\mathrm{I}_{\text {S }}$ | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  |  | －6．5 | A |
| Pulse Diode Forward Current | $\mathrm{I}_{\text {SM }}$ |  |  |  | － 30 |  |
| Body Diode Voltage | $\mathrm{V}_{\text {SD }}$ | $\mathrm{I}_{\mathrm{S}}=-5.6 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | － 0.71 | －1．2 | V |
| Body Diode Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\mathrm{I}_{\mathrm{F}}=-5.6 \mathrm{~A}, \mathrm{dl} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}, \mathrm{T}_{J}=25^{\circ} \mathrm{C}$ |  | 22 | 33 | ns |
| Body Diode Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{rr}}$ |  |  | 17 | 26 | nC |
| Reverse Recovery Fall Time | $\mathrm{t}_{\mathrm{a}}$ |  |  | 13 |  | ns |
| Reverse Recovery Rise Time | $\mathrm{t}_{\mathrm{b}}$ |  |  | 9 |  | ns |

## Notes：

a．Pulse test；pulse width $\leq 300 \mu \mathrm{~s}$ ，duty cycle $\leq 2 \%$ ．
b．Guaranteed by design，not subject to production testing．

[^0]TYPICAL CHARACTERISTICS $25^{\circ} \mathrm{C}$ ，unless otherwise noted





On－Resistance vs．Drain Current


TYPICAL CHARACTERISTICS $25^{\circ} \mathrm{C}$ ，unless otherwise noted



Safe Operating Area

TYPICAL CHARACTERISTICS $25^{\circ} \mathrm{C}$ ，unless otherwise noted


＊The power dissipation $P_{D}$ is based on $T_{J(\max )}=150^{\circ} \mathrm{C}$ ，using junction－to－case thermal resistance，and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used．It is used to determine the current rating，when this rating falls below the package limit．

TYPICAL CHARACTERISTICS $25^{\circ} \mathrm{C}$ ，unless otherwise noted


Normalized Thermal Transient Impedance，Junction－to－Ambient


SOIC（NARROW）：8－LEAD
JEDEC Part Number：MS－012


| DIM | MILLIMETERS |  | INCHES |  |
| :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |
| A | 1.35 | 1.75 | 0.053 | 0.069 |
| $\mathrm{~A}_{1}$ | 0.10 | 0.20 | 0.004 | 0.008 |
| B | 0.35 | 0.51 | 0.014 | 0.020 |
| C | 0.19 | 0.25 | 0.0075 | 0.010 |
| D | 4.80 | 5.00 | 0.189 | 0.196 |
| E | 3.80 | 4.00 | 0.150 | 0.157 |
| e | 1.27 BSC |  | 0.050 BSC |  |
| H | 5.80 | 6.20 | 0.228 | 0.244 |
| h | 0.25 | 0.50 | 0.010 | 0.020 |
| L | 0.50 | 0.93 | 0.020 | 0.037 |
| q | $0^{\circ}$ | $8^{\circ}$ | $0^{\circ}$ | $8^{\circ}$ |
| S | 0.44 | 0.64 | 0.018 | 0.026 |
| ECN：C－06527－Rev．I，11－Sep－06 |  |  |  |  |
| DWG：5498 |  |  |  |  |

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## RECOMMENDED MINIMUM PADS FOR SO－8



Recommended Minimum Pads
Dimensions in Inches／（mm）

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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7 STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP NTMC083NP10M5L BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2 BSO203SP BSO211P IPA60R230P6


[^0]:    Stresses beyond those listed under＂Absolute Maximum Ratings＂may cause permanent damage to the device．These are stress ratings only，and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied．Exposure to absolute maximum rating conditions for extended periods may affect device reliability．

